## Notice of References Cited Application/Control No. 10/773,565 Examiner Thanh T. Nguyen Applicant(s)/Patent Under Reexamination WU ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0077175	04-2004	Hsieh et al.	438/694
	В	US-2004/0106297	06-2004	Kanegae et al.	438/725
	С	US-6,472,231	10-2002	Gabriel et al.	438/9
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	х	

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